Search Notes



Application/Control No.

10737339 Examiner Applicant(s)/Patent Under Reexamination FANG ET AL.

FANG

Art Unit

Haile, Awet A 2616

SEARCHED

Class	Subclass	Date	Examiner
370	208	4/7/2008	Awet Haile
370	210	4/7/2008	Awet Haile
370	479	4/7/2008	Awet Haile
370	260	4/7/2008	Awet Haile
370	281	4/7/2008	Awet Haile
370	392	14/7/2008	Awet Haile
370	393	4/7/2008	Awet Haile
370	474	4/7/2008	Awet Haile
370	475	4/7/2008	Awet Haile
370	476	4/7/2008	Awet Haile
370	480	4/7/2008	Awet Haile

SEARCH	NOTES
--------	-------

Search Notes	Date	Examiner
East search	4/14/2008	Awet Haile

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner

U.S. Patent and Trademark Office Part of Paper No.: